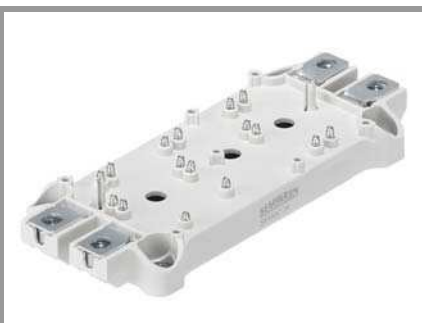


SEMiX453GAL12E4s



SEMiX® 3s

Trench IGBT Modules

SEMiX453GAL12E4s

Features

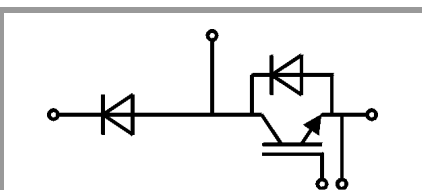
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- UL recognized, file no. E63532

Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Product reliability results are valid for $T_j=150^\circ\text{C}$
- Dynamic values apply to the following combination of resistors:
 $R_{Gon,main} = 1,0 \Omega$
 $R_{Goff,main} = 1,0 \Omega$
 $R_{G,X} = 2,2 \Omega$
 $R_{E,X} = 0,5 \Omega$



GAL

Absolute Maximum Ratings				
Symbol	Conditions		Values	Unit
IGBT				
V_{CES}	$T_j = 25^\circ\text{C}$		1200	V
I_C	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	683	A
		$T_c = 80^\circ\text{C}$	526	A
I_{Cnom}			450	A
I_{CRM}	$I_{CRM} = 3 \times I_{Cnom}$		1350	A
V_{GES}			-20 ... 20	V
t_{psc}	$V_{CC} = 800\text{ V}$ $V_{GE} \leq 20\text{ V}$ $V_{CES} \leq 1200\text{ V}$	$T_j = 150^\circ\text{C}$	10	μs
T_j			-40 ... 175	$^\circ\text{C}$
Inverse diode				
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	544	A
		$T_c = 80^\circ\text{C}$	407	A
I_{Fnom}			450	A
I_{FRM}	$I_{FRM} = 3 \times I_{Fnom}$		1350	A
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		2430	A
T_j			-40 ... 175	$^\circ\text{C}$
Freewheeling diode				
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	544	A
		$T_c = 80^\circ\text{C}$	407	A
I_{Fnom}			450	A
I_{FRM}	$I_{FRM} = 3 \times I_{Fnom}$		1350	A
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		2430	A
T_j			-40 ... 175	$^\circ\text{C}$
Module				
$I_{t(RMS)}$	$T_{terminal} = 80^\circ\text{C}$		600	A
T_{stg}			-40 ... 125	$^\circ\text{C}$
V_{isol}	AC sinus 50Hz, $t = 1\text{ min}$		4000	V

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
$V_{CE(sat)}$	$I_C = 450\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.8	2.05		V
		$T_j = 150^\circ\text{C}$	2.2	2.4		V
V_{CE0}	chipelevel	$T_j = 25^\circ\text{C}$	0.8	0.9		V
		$T_j = 150^\circ\text{C}$	0.7	0.8		V
r_{CE}	$V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	2.2	2.6		$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	3.3	3.6		$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE}=V_{CE}, I_C = 18\text{ mA}$		5	5.8	6.5	V
I_{CES}	$V_{GE} = 0\text{ V}$ $V_{CE} = 1200\text{ V}$	$T_j = 25^\circ\text{C}$			5	mA
		$T_j = 150^\circ\text{C}$				mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$		27.9		nF
C_{oes}		$f = 1\text{ MHz}$		1.74		nF
C_{res}		$f = 1\text{ MHz}$		1.53		nF
Q_G	$V_{GE} = -8\text{ V...} + 15\text{ V}$			2550		nC
R_{Gint}	$T_j = 25^\circ\text{C}$			1.67		Ω

SEMiX453GAL12E4s



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- High short circuit capability
- UL recognized, file no. E63532

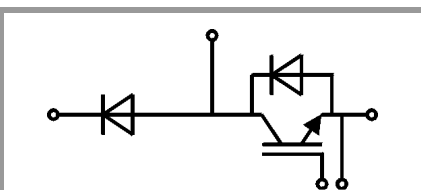
Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Product reliability results are valid for $T_j=150^\circ\text{C}$
- Dynamic values apply to the following combination of resistors:
 $R_{Gon,main} = 1,0 \Omega$
 $R_{Goff,main} = 1,0 \Omega$
 $R_{G,X} = 2,2 \Omega$
 $R_{E,X} = 0,5 \Omega$

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
$t_{d(on)}$	$V_{CC} = 600 \text{ V}$	$T_j = 150^\circ\text{C}$		336		ns
t_r	$I_C = 450 \text{ A}$	$T_j = 150^\circ\text{C}$		80		ns
E_{on}	$V_{GE} = \pm 15 \text{ V}$	$T_j = 150^\circ\text{C}$		45		mJ
$t_{d(off)}$	$R_{G on} = 1.9 \Omega$	$T_j = 150^\circ\text{C}$		615		ns
t_f	$R_{G off} = 1.9 \Omega$	$T_j = 150^\circ\text{C}$		130		ns
E_{off}	$di/dt_{on} = 4000 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		66.5		mJ
	$di/dt_{off} = 5000 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$				
$R_{th(j-c)}$	per IGBT				0.065	K/W
Inverse diode						
$V_F = V_{EC}$	$I_F = 450 \text{ A}$	$T_j = 25^\circ\text{C}$		2.1	2.46	V
	$V_{GE} = 0 \text{ V}$	$T_j = 150^\circ\text{C}$		2.1	2.4	V
	chiplevel					
V_{F0}		$T_j = 25^\circ\text{C}$	1.1	1.3	1.5	V
	chiplevel	$T_j = 150^\circ\text{C}$	0.7	0.9	1.1	V
r_F		$T_j = 25^\circ\text{C}$	1.4	1.9	2.1	m Ω
	chiplevel	$T_j = 150^\circ\text{C}$	2.2	2.6	2.8	m Ω
I_{RRM}	$I_F = 450 \text{ A}$	$T_j = 150^\circ\text{C}$		350		A
Q_{rr}	$di/dt_{off} = 5000 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		70		μC
E_{rr}	$V_{GE} = -15 \text{ V}$	$T_j = 150^\circ\text{C}$		28		mJ
	$V_{CC} = 600 \text{ V}$	$T_j = 150^\circ\text{C}$				
$R_{th(j-c)}$	per diode				0.11	K/W
Freewheeling diode						
$V_F = V_{EC}$	$I_F = 450 \text{ A}$	$T_j = 25^\circ\text{C}$		2.1	2.46	V
	$V_{GE} = 0 \text{ V}$	$T_j = 150^\circ\text{C}$		2.1	2.4	V
	chiplevel					
V_{F0}		$T_j = 25^\circ\text{C}$	1.1	1.3	1.5	V
	chiplevel	$T_j = 150^\circ\text{C}$	0.7	0.9	1.1	V
r_F		$T_j = 25^\circ\text{C}$	1.4	1.9	2.1	m Ω
	chiplevel	$T_j = 150^\circ\text{C}$	2.2	2.6	2.8	m Ω
I_{RRM}	$I_F = 450 \text{ A}$	$T_j = 150^\circ\text{C}$		350		A
Q_{rr}	$di/dt_{off} = 5000 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		70		μC
E_{rr}	$V_{GE} = -15 \text{ V}$	$T_j = 150^\circ\text{C}$		28		mJ
	$V_{CC} = 600 \text{ V}$	$T_j = 150^\circ\text{C}$				
$R_{th(j-c)}$	per diode				0.11	K/W
Module						
L_{CE}				20		nH
R_{CC+EE}	res., terminal-chip	$T_C = 25^\circ\text{C}$		0.7		m Ω
		$T_C = 125^\circ\text{C}$		1		m Ω
$R_{th(c-s)}$	per module			0.04		K/W
M_s	to heat sink (M5)		3		5	Nm
M_t		to terminals (M6)	2.5		5	Nm
						Nm
w					300	g
Temperature Sensor						
R_{100}	$T_C=100^\circ\text{C}$ ($R_{25}=5 \text{ k}\Omega$)			$493 \pm 5\%$		Ω
$B_{100/125}$	$R(T)=R_{100}\exp[B_{100/125}(1/T-1/T_{100})]$; $T[\text{K}]$;			$3550 \pm 2\%$		K



GAL

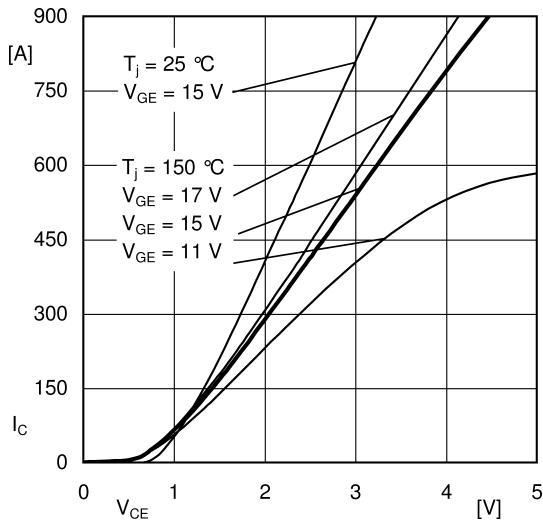


Fig. 1: Typ. output characteristic, inclusive $R_{CC'+EE'}$

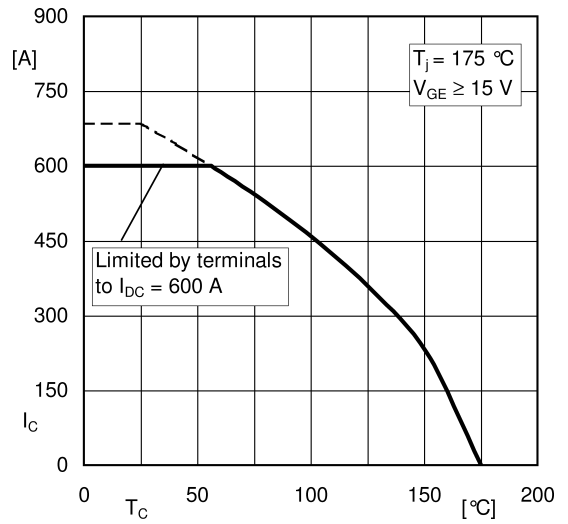


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

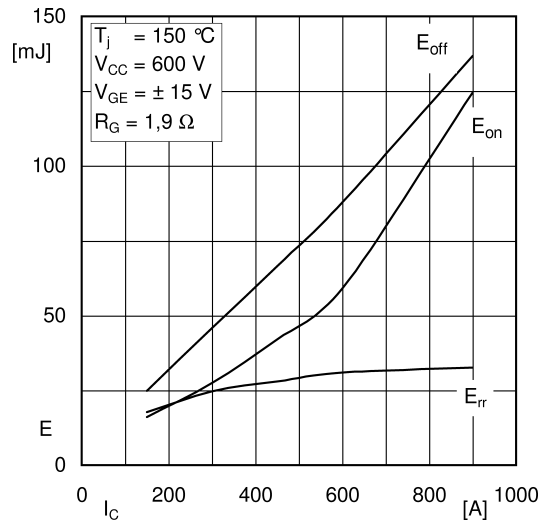


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

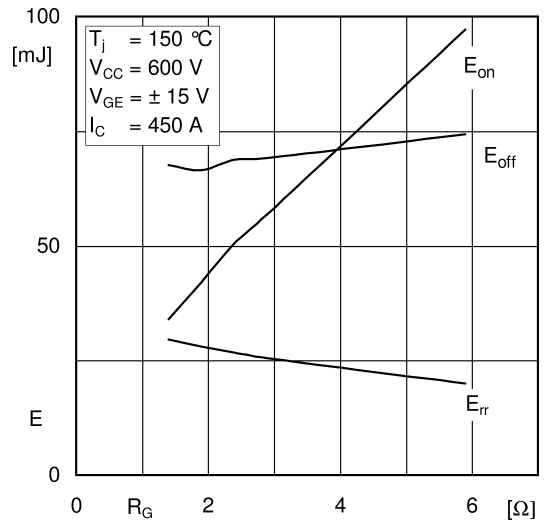


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

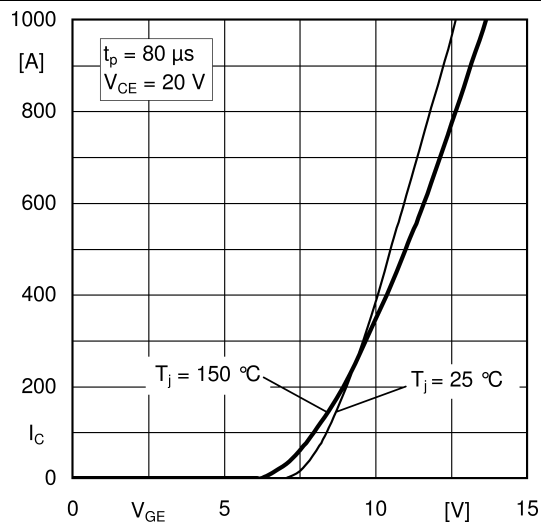


Fig. 5: Typ. transfer characteristic

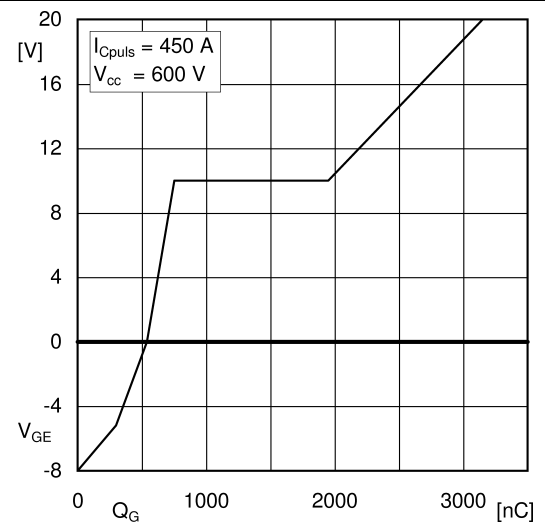
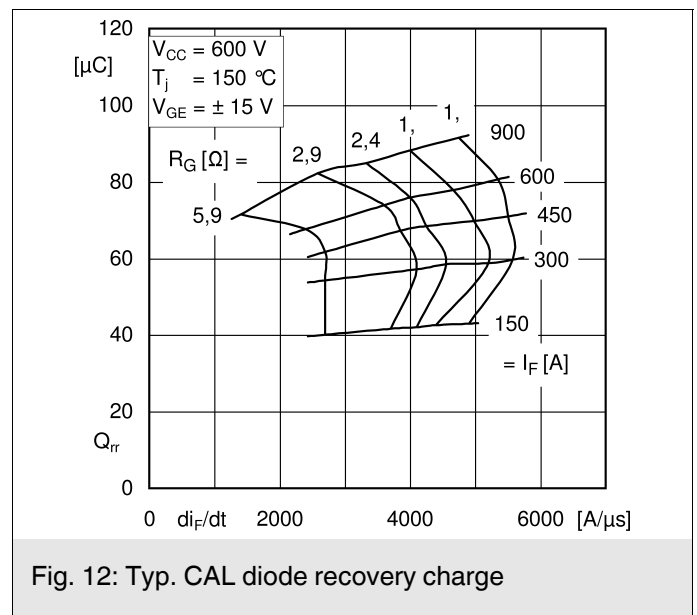
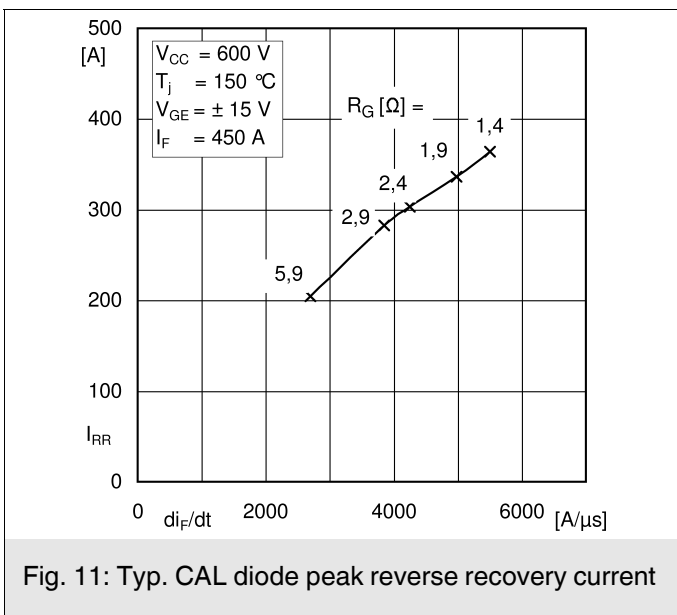
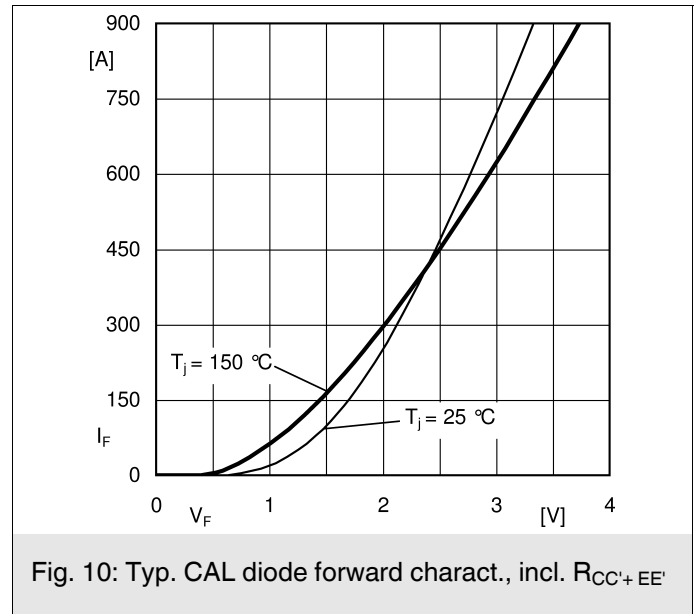
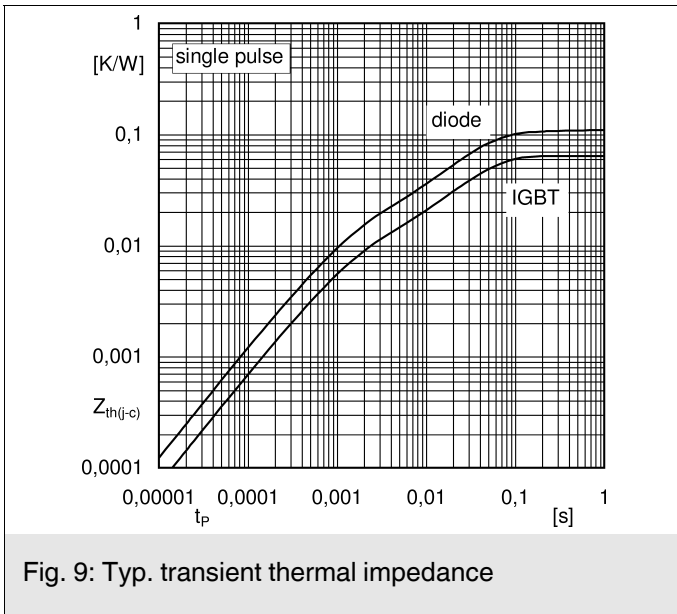
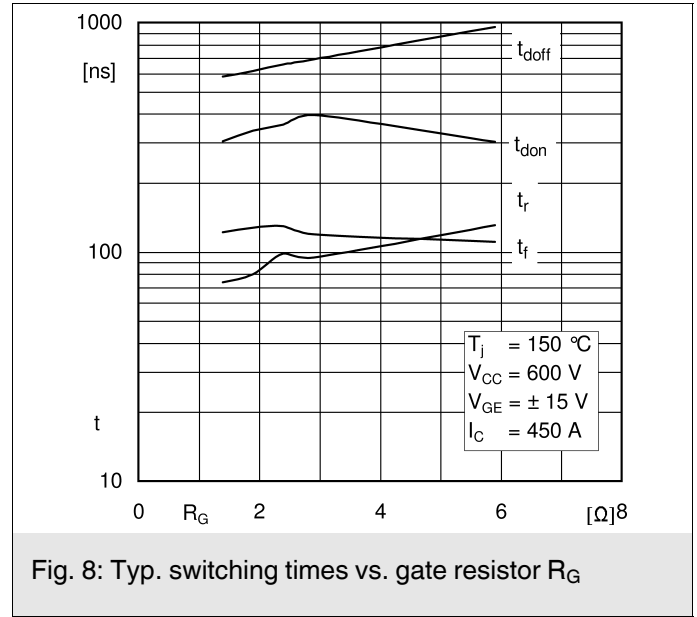
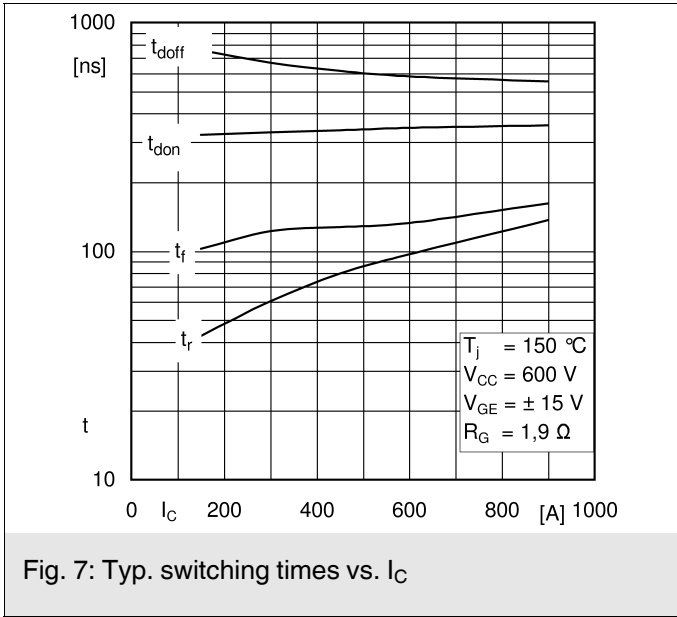


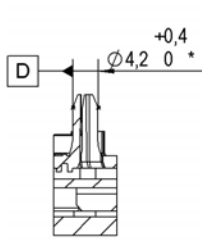
Fig. 6: Typ. gate charge characteristic



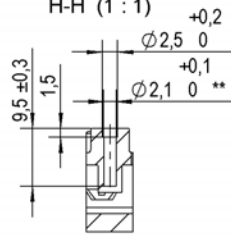
SEMiX453GAL12E4s

Case: SEMiX 3s

guide pin left
F-F (1 : 1)



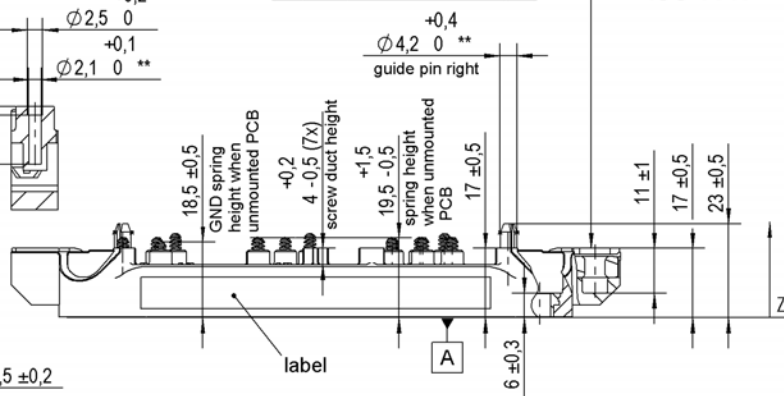
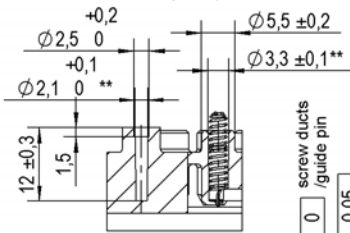
screw duct
(1x centre):
H-H (1 : 1)



	0,3	connector 1-2 / 3-4
	0,2	each connector

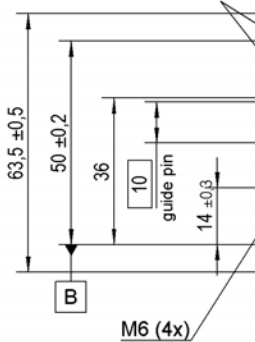
general tolerance:
ISO 2768-m
ISO 8015

screw duct (6x)
spring duct (16x):
G-G (1 : 1)

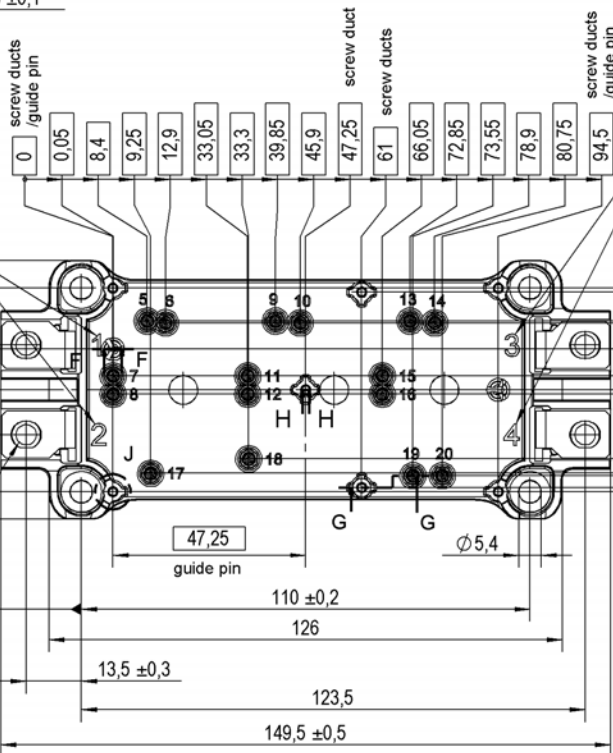


All measures in Z-direction
valid when mounted to heat sink

marking of
terminals



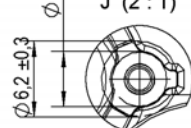
marking of
terminals



marking of
terminals

- 15 screw ducts
- 14 screw duct
- 6,9
- 6,45
- 0 guide pin
- 6,55
- 10 screw duct /guide pin
- 11,05
- 26,95
- 30,5
- 31,05
- 34 screw duct
- 35 screw ducts

screw duct
top view(7x):
J (2 : 1)



*guide pin left with

	0,25	A	B	C
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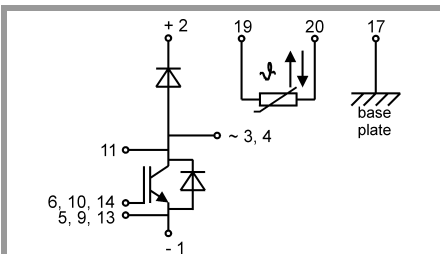
**screw ducts / spring ducts / guide pin right with

	0,5	A	B	D
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Rules for the contact PCB:

- holes guidepins = $\varnothing 4 \pm 0,1$ / position tolerance $\pm 0,1$
- holes for screws = $\varnothing 3,3 \pm 0,1$ / position tolerance $\pm 0,1$
- spring contact pad = $\varnothing 3,6 \pm 0,1$ / position tolerance $\pm 0,1$

SEMiX 3s



spring configuration

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.